

Form PTO 1449
(Modified)

AUG 23 2004

DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

251578US2

SERIAL NO.

10/822,177

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Mitsuhiro NOGUCHI, et al.

FILING DATE

April 12, 2004

GROUP

2655- 2824

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
VIN	AA	6,411,548	06/25/02	SAKUI et al.			
	AB	US 2002/0159315	10/31/02	NOGUCHI et al.			
	AC	US 2002/0141242	10/03/02	NOGUCHI et al.			
	AD	US 2003/0042558	03/06/03	NOGUCHI et al.			
VIN	AE	US 2004/0094793	05/20/04	NOGUCHI et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

W. H. Ngn

Date Considered

10/26/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1516
(Modified)

AUG 23 2004

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
VTN	AA	6,049,899	04/11/2000	D. L. AUCLAIR, et al.			
VTN	AB	6,215,148	04/10/2001	B. EITAN			
NTN	AC	6,201,282	03/13/2001	B. EITAN			
	AD						
	AE						
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	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
VTN	AO	8-279295	10/22/1996	JAPAN (with English Abstract)		X
VTN	AP	11-330277	11/30/1999	JAPAN (with English Abstract)		X
VTN	AQ	2002-150783	05/24/2002	JAPAN (with English Abstract)		X
	AR					
	AS					
	AT					
	AU					
	AV					

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☐ Additional References sheet(s) attached

Examiner

W. H. K. K.

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